## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10777470	LEE ET AL.
Examiner	Art Unit
Mui, Christine T	1709

SEARCHED				
Class	Subclass	Date	Examiner	
204	450	07.11.2007	CTM	
366	341	07.11.2007	CTM	
422	100, 101	07.11.2007	CTM	
435	287.3	07.11.2007	CTM	
436	052	07.11.2007	CTM	
516	073	07.30.2007	CTM	

SEARCH NOTES			
Search Notes	Date	Examiner	
See EAST Search Report	07.10.2007	CTM	
See Updated EAST Search Report	07 April 2008	CTM	
See Updated EAST Search Report	17 December 2008	СТМ	
See Updated EAST Search Report	07 April 2009	CTM	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	See Interference Search Report	07 April 2009	CTM

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